

Search Notes**Application/Control No.**

10/721,745

Examiner

Yennhu B. Huynh

Applicant(s)/Patent under Reexamination

HEDLER ET AL.

Art Unit

2813

SEARCHED

Class	Subclass	Date	Examiner
138	106 108	4/12/05	yf
	612 614		
	123		
	116		
	120 127		
257	778	4/13/05	
	738		
	781		
	668		
	680		
	747		
	737		
	795		yf

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

S. east/west
USPTO EPO JPO
Derwent IBMTDB

4/13/05 yf

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner